INTERNATIONAL STANDARD

INTERNATIONAL ORGANIZATION FOR STANDARDIZATION MEXCHAPODHAR OPPAHUSALUR IIO СТАНДАРТИЗАЦИИ ORGANISATION INTERNATIONALE DE NORMALISATION

Sampling procedures and tables for inspection by attributes

Règles et tables d'échantillonnage pour les contrôles par attributs

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FOREWORD

ISO (the International Organization for Standardization) is a worldwide federation of national standards institutes (ISO Member Bodies). The work of developing International Standards is carried out through ISO Technical Committees. Every Member Body interested in a subject for which a Technical Committee has been set up has the right to be represented on that Committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work.

Draft International Standards adopted by the Technical Committees are circulated to the Member Bodies for approval before their acceptance as International Standards by the ISO Council.

International Standard ISO 2859 (which is identical, except for relatively few editorial changes, to the IEC Publication 410), was drawn up by Technical Committee ISO/TC 69, *Applications of statistical methods*, and circulated to the Member Bodies in March 1973.

It has been approved by the Member Bodies of the following countries74

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Australia	India	3f0f2049Romania2859-1974
Austria	Ireland	South Africa, Rep. of
Belgium	Israel	Spain
Bulgaria	Italy	Switzerland
Chile	Japan	Thailand
Czechoslovakia	Mexico	Turkey
Egypt, Arab Rep. of	Netherlands	United Kingdom
France	New Zealand	U.S.A.
Hungary	Poland	U.S.S.R.

The Member Bodies of the following countries expressed disapproval of the document on technical grounds :

Germany Sweden

ISO 3319¹), Guide for the use of ISO 2859 "Sampling procedures and tables for inspection by attributes", provides information concerning methods of sampling inspection with particular reference to the sampling procedures and tables given in this International Standard.

The definitions given herein are not intended to be complete. Reference should be made to ISO 3534, *Statistical vocabulary*, $^{1)}$ in particular to clauses 2 and 4.

1) At present at the stage of draft.

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Sampling procedures and tables for inspection by attributes

1 SCOPE AND FIELD OF APPLICATION

1.1 Purpose

This International Standard specifies sampling plans and procedures for inspection by attributes. When specified by the responsible authority, this International Standard shall be "referenced" in the specification, contract, inspection instructions, or other documents, and the provisions set forth herein shall govern. The "responsible authority" shall be designated in one of the above documents.

1.5 Unit of product

The unit of product is the thing inspected in order to determine its classification as defective or non-defective or to count the number of defects. It may be a single article, a pair, a set, a length, an area, an operation, a volume, a component of an end product, or the end product itself. The unit of product may or may not be the same as the unit of purchase, supply, production, or shipment.

1.2 Field of application

'eh Sampling plans designated in this publication are applicable, but not limited, to inspection of the following:

ISO 2859:197

- a) end items;
- b) components and raw materials; nttps://standards.iteh.ai/catalog/standards/sis
- c) operations;
- d) materials in process;
- e) supplies in storage;
- f) maintenance operations;
- data or records; a)
- h) administrative procedures.

These plans are intended primarily to be used for a continuing series of lots or batches. The plans may also be used for the inspection of isolated lots or batches, but, in this latter case, the user is cautioned to consult the operating characteristic curves to find a plan which will yield the desired protection (see 11.6).

1.3 Inspection

Inspection is the process of measuring, examining, testing, or otherwise comparing the unit of product (see 1.5) with the requirements.

1.4 Inspection by attributes

Inspection by attributes is inspection whereby either the unit of product is classified simply as defective or non-defective, or the number of defects in the unit of product is counted, with respect to a given requirement or set of requirements.

2 CLASSIFICATION OF DEFECTS AND DEFECTIVES

2.1 Method of classifying defects

A classification of defects is the enumeration of possible defects of the unit of product classified according to their seriousness. A defect is any non-conformance of the unit of product to specified requirements. Defects will normally be 3f0f2049cb54/iso-28: grouped into one or more of the following classes; however, defects may be grouped into other classes, or into sub-classes within these classes.

2.1.1 Critical defect

A critical defect is a defect that judgment and experience indicate is likely to result in hazardous or unsafe conditions for individuals using, maintaining, or depending upon the product; or a defect that judgment and experience indicate is likely to prevent performance of the tactical function of a major end item such as a ship, aircraft, computer, medical equipment or telecommunication satellite.

NOTE - For a special provision relating to critical defects, see 6.3.

2.1.2 Major defect

A major defect is a defect, other than critical, that is likely to result in failure, or to reduce materially the usuability of the unit of product for its intended purpose.

2.1.3 Minor defect

A minor defect is a defect that is not likely to reduce materially the usability of the unit of product for its intended purpose, or is a departure from established standards having little bearing on the effective use or operation of the unit.

2.2 Method of classifying defectives

A defective is a unit of product which contains one or more defects. Defectives will usually be classified as follows :

2.2.1 Critical defective

A critical defective contains one or more critical defects and may also contain major and/or minor defects.

 $\mathsf{NOTE}-\mathsf{For}\ \mathsf{a}\ \mathsf{special}\ \mathsf{provision}\ \mathsf{relating}\ \mathsf{to}\ \mathsf{critical}\ \mathsf{defectives},\ \mathsf{see}\ \mathbf{6.3.}$

2.2.2 Major defective

A major defective contains one or more major defects, and may also contain minor defects but contains no critical defects.

2.2.3 Minor defective

A minor defective contains one or more minor defects but contains no critical or major defect.

3 PERCENT DEFECTIVE AND DEFECTS PER HUNDRED UNITS

3.1 Expression of non-conformance

The extent of non-conformance of product shall be expressed either in terms of percent defective or in terms of defects per hundred units.

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3.2 Percent defective

The percent defective of any given quantity of units of product is one hundred times the number of defective units of product contained therein divided by the total number of units or product, i.e. :

Percent defective =
$$\frac{\text{Number of defectives}}{\text{Number of units inspected}} \times 100$$

3.3 Defects per hundred units

The number of defects per hundred units of any given quantity of units of product is one hundred times the number of defects contained therein (one or more defects being possible in any unit of product) divided by the total number of units of product, i.e. :

Defects per hundred units =

Number of defects Number of units inspected

4 ACCEPTABLE QUALITY LEVEL (AQL)

4.1 Use

The AQL, together with the sample size code letter, is used for indexing the sampling plans provided herein.

4.2 Definition

The AQL is the maximum percent defective (or the maximum number of defects per hundred units) that, for purposes of sampling inspection, can be considered satisfactory as a process average (see 11.2).

4.3 Note on the meaning of AQL

When a consumer designates some specific value of AQL for a certain defect or group of defects, he indicates to the supplier that his (the consumer's) acceptance sampling plan will accept the great majority of the lots or batches that the supplier submits, provided the process average level of percent defective (or defects per hundred units) in these lots or batches be no greater than the designated value of AQL. Thus, the AQL is a designated value of percent defective (or defects per hundred units) that the consumer indicates will be accepted most of the time by the acceptance sampling procedure to be used. The sampling plans provided herein are so arranged that the probability of acceptance at the designated AQL value depends upon the sample size, being generally higher for large samples than for small ones, for a given AQL. The AQL alone does not describe the protection to the consumer for individual lots or batches but more directly related to what might be expected from a series of lots or batches, provided the steps indicated in this International Standard are taken. It is necessary to refer to the operating characteristic curve of the plan, to determine what protection the consumer will

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⁴The designation of an AQL shall not imply that the supplier has the right to supply knowingly any defective unit of product.

4.5 Specifying AQLs

The AQL to be used will be designated in the contract or by the responsible authority. Different AQLs may be designated for groups of defects considered collectively, or for individual defects. An AQL for a group of defects may be designated in addition to AQLs for individual defects, or sub-groups, within that group. AQL values of 10,0 or less may be expressed either in percent defective or in defects per hundred units; those over 10,0 shall be expressed in defects per hundred units only.

4.6 Preferred AQLs

The values of AQLs given in these tables are known as preferred AQLs. If, for any product, an AQL be designated other than a preferred AQL, these tables are not applicable.

5 SUBMISSION OF PRODUCT

5.1 Lot or batch

The term lot or batch shall mean "inspection lot" or "inspection batch", i.e., a collection of units of product from which a sample is to be drawn and inspected to determine conformance with the acceptability criteria, and may differ from a collection of units designated as a lot or batch for other purposes (e.g. production, shipment, etc.).

5.2 Formation of lots or batches

The product shall be assembled into identifiable lots, sub-lots, batches, or in such other manner as may be prescribed (see 5.4). Each lot or batch shall, as far as is practicable, consist of units of product of a single type, grade, class, size, and composition, manufactured under essentially the same conditions, and at essentially the same time.

5.3 Lot or batch size

The lot or batch size is the number of units of product in a lot or batch.

5.4 Presentation of lots or batches

The formation of the lots or batches, lot or batch size, and the manner in which each lot or batch is to be presented and identified by the supplier shall be designated or approved by the responsible authority. As necessary, the supplier shall provide adequate and suitable storage space for each lot or batch, equipment needed for properidentification and presentation, and personnel for all handling of product required for drawing of samples.

6.4 Resubmitted lots or batches

Lots or batches found unacceptable shall be resubmitted for reinspection only after all units are re-examined or retested and all defective units are removed or defects corrected. The responsible authority shall determine whether normal or tightened inspection shall be used, and whether reinspection shall include all types or classes of defects or only the particular types or classes of defects which caused initial rejection.

7 DRAWING OF SAMPLES

7.1 Sample

A sample consists of one or more units of product drawn from a lot or batch, the units of the sample being selected at random without regard to their quality. The number of units of product in the sample is the sample size.

7.2 Representative sampling

When appropriate, the number of units in the sample shall be selected in proportion to the size of sub-lots or sub-batches, or parts of the lot or batch, identified by some rational criterion. When representative sampling is used, the units from each part of the lot or batch shall be selected at random.

7.3 Time of sampling

ISO 2859:1974 Samples may be drawn after all the units comprising the lot https://standards.iteh.ai/catalog/standards/sist/or_batch_baye_been_assembled, or samples may be drawn 3f0f2049cb54/iso-2859-11/9

6 ACCEPTANCE AND REJECTION

6.1 Acceptability of lots or batches

Acceptability of a lot or batch will be determined by the use of a sampling plan or plans associated with the designated AQL or AQLs.

6.2 Defective units

The right is reserved to reject any unit of product found defective during inspection whether that unit of product forms part of a sample or not, and whether the lot or batch as a whole is accepted or rejected. Rejected units may be repaired or corrected and resubmitted for inspection with the approval of, and in the manner specified by, the responsible authority.

6.3 Special reservation for critical defects

The supplier may be required at the discretion of the responsible authority to inspect every unit of the lot or batch for critical defects. The right is reserved to inspect every unit submitted by the supplier for critical defects, and to reject the lot or batch immediately, when a critical defect is found. The right is reserved also to sample, for critical defects, every lot or batch submitted by the supplier and to reject any lot or batch if a sample drawn therefrom is found to contain one or more critical defects.

7.4 Double or multiple sampling

When double or multiple sampling is to be used, each sample shall be selected over the entire lot or batch.

8 NORMAL, TIGHTENED AND REDUCED INSPECTION

8.1 Initiation of inspection

Normal inspection will be used at the start of inspection unless otherwise directed by the responsible authority.

8.2 Continuation of inspection

Normal, tightened or reduced inspection shall continue unchanged for each class of defects or defectives on successive lots or batches except where the switching procedures given below require a change. The switching procedures shall be applied to each class of defects or defectives independently.

8.3 Switching procedures

8.3.1 Normal to tightened

When normal inspection is in effect, tightened inspection shall be instituted when 2 out of 5 consecutive lots or batches have been rejected on original inspection (i.e. ignoring resubmitted lots or batches for this procedure).

8.3.2 Tightened to normal

When tightened inspection is in effect, normal inspection shall be instituted when 5 consecutive lots or batches have been considered acceptable on original inspection.

8.3.3 Normal to reduced

When normal inspection is in effect, reduced inspection may be instituted providing that all of the following conditions are satisfied :

a) The preceding 10 lots or batches (or more, as indicated by the note to table VIII) have been on normal inspection and none has been rejected on original inspection.

b) The total number of defectives (or defects) in the samples from the preceding 10 lots or batches (or such other number as was used for condition (a) above) is equal to or less than the applicable number given in table VIII. If double or multiple sampling is in use, all samples inspected should be included, not "first" samples only.

c) Production is at a steady rate.

d) Reduced inspection is considered desirable by the RD PREVIEW responsible authority.

8.3.4 Reduced to normal

When reduced inspection is in effect, normal inspection shall be instituted if any of the following occur on original inspection : 3f0f2049cb5

a) A lot or batch is rejected.

b) A lot or batch is considered acceptable under the procedures of 10.1.4.

c) Production becomes irregular or delayed.

d) Other conditions warrant that normal inspection shall be instituted.

8.4 Discontinuation of inspection

In the event that 10 consecutive lots or batches remain on tightened inspection (or such other number as may be designated by the responsible authority), inspection under the provisions of this document should be discontinued pending action to improve the quality of submitted material.

SAMPLING PLANS

9.1 Sampling plan

A sampling plan indicates the number of units of product from each lot or batch which are to be inspected (sample size or series of sample sizes) and the criteria for determining the acceptability of the lot or batch (acceptance and rejection numbers).

9.2 Inspection level

The inspection level determines the relationship between the lot or batch size and the sample size. The inspection level to be used for any particular requirement will be prescribed by the responsible authority. Three inspection levels : I, II and III, are given in table I for general use. Unless otherwise specified, Inspection Level II will be used. However, Inspection Level I may be specified when less discrimination is needed, or Level III may be specified for greater discrimination. Four additional special levels : S-1, S-2, S-3 and S-4, are given in the same table and may be used where relatively small sample sizes are necessary and large sampling risks can or must be tolerated.

NOTE -- In the designation of inspection levels S-1 to S-4, it is essential that care is exercised to avoid AQLs inconsistent with these inspection levels.

9.3 Code letters

Sample sizes are designated by code letters. Table I shall be used to find the applicable code letter for the particular lot or batch size and the prescribed inspection level.

9.4 Obtaining sampling plan (standar as.iten.ai

The AQL and the code letter shall be used to obtain the sampling plan from tables II, III or IV. When no sampling plan is available for a given combination of AQL and code letter, the tables direct the user to a different letter. The sample size to be used is given by the new code letter, not by the original letter. If this procedure leads to different sample sizes for different classes of defects, the code letter corresponding to the largest sample size derived may be used for all classes of defects when designated or approved by the responsible authority. As an alternative to a single sampling plan with an acceptance number of 0, the plan with an acceptance number of 1, with its correspondingly larger sample size for a designated AQL (where available), may be used when designated or approved by the responsible authority.

9.5 Types of sampling plan

Three types of sampling plan : single, double and multiple, are given in tables II, III and IV respectively. When several types of plan are available for a given AQL and code letter, any one may be used. A decision as to the type of plan, either single, double, or multiple, when available for a given AQL and code letter, will usually be based upon the comparison between the administrative difficulty and the average sample sizes of the available plans. The average sample size of multiple plans is less than for double (except in the case corresponding to single acceptance number 1) and both of these are always less than a single sample size. Usually the administrative difficulty for single sampling and the cost per unit of the sample are less than for double or multiple.

10 DETERMINATION OF ACCEPTABILITY

10.1 Percent defective inspection

To determine acceptability of a lot or batch under percent defective inspection, the applicable sampling plan shall be used in accordance with 10.1.1, 10.1.2, 10.1.3 and 10.1.4.

10.1.1 Single sampling plan

The number of sample units inspected shall be equal to the sample size given by the plan. If the number of defectives found in the sample is equal to or less than the acceptance number, the lot or batch shall be considered acceptable. If the number of defectives is equal to or greater than the rejection number, the lot or batch shall be rejected.

10.1.2 Double sampling plan

The number of sample units inspected shall be equal to the first sample size given by the plan. If the number of defectives found in the first sample is equal to or less than the first acceptance number, the lot or batch shall be considered acceptable.

If the number of defectives found in the first sample is equal to or greater than the first rejection number, the lot or batch shall be rejected. If the number of defectives 11.2 Process average found in the first sample is between the first acceptance and rejection numbers, a second sample of the size given by the plan shall be inspected. The number of defectives found in the first and second samples shall be accumulated stift theds/sist second acceptance number, the lot or batch shall be considered acceptable. If the cumulative number of defectives is equal to or greater than the second rejection number, the lot or batch shall be rejected.

10.1.3 Multiple sampling plan

Under multiple sampling, the procedure shall be similar to that specified in 10.1.2, except that the number of successive samples required to reach a decision may be more than two.

10.1.4 Special procedure for reduced inspection

Under reduced inspection, the sampling procedure may terminate without either acceptance or rejection criteria having been met. In these circumstances, the lot or batch will be considered acceptable, but normal inspection will be reinstated starting with the next lot or batch (see 8.3.4 (b)).

10.2 Defects per hundred units inspection

To determine the acceptability of a lot or batch under defects per hundred units inspection, the procedure specified for percent defective inspection above shall be used, except that the word "defects" shall be substituted for "defectives".

11 SUPPLEMENTARY INFORMATION

11.1 Operating characteristic curves

The operating characteristic curves for normal inspection. shown in table X, indicate the percentage of lots or batches which may be expected to be accepted under the various sampling plans for a given process quality. The curves shown are for single sampling; curves for double and multiple sampling are matched as closely as practicable. The O.C. curves shown for AQLs greater than 10,0 are based on the Poisson distribution and are applicable for defects per hundred units inspection; those for AQLs of 10,0 or less and sample sizes of 80 or less are based on the binomial distribution and are applicable for percent defective inspection; those for AQLs of 10.0 or less and sample sizes larger than 80 are based on the Poisson distribution and are applicable either for defects per hundred units inspection, or for percent defective inspection (the Poisson distribution being an adequate approximation to the binomial distribution under these conditions).

Tabulated values, corresponding to selected values of probabilities of acceptance (P_a , in percent) are given for each of the curves shown, and, in addition, for tightened inspection, and for defects per hundred units for AQLs of 10,0 or less and sample sizes of 80 or less.

The process average is the average percent defective or average number of defects per hundred units (whichever is applicable) 9 of 4 product 7-submitted by the supplier for cumulative number of defectives is equal to or less than the -285 original inspection. Original inspection is the first inspection of a particular quantity of product as distinguished from the inspection of product which has been resubmitted after prior rejection.

11.3 Average outgoing quality (AOQ)

The AOQ is the average quality of outgoing product including all accepted lots or batches, plus all rejected lots or batches after the rejected lots or batches have been effectively 100 % inspected and all defectives replaced by non-defectives.

11.4 Average outgoing quality limit (AOQL)

The AOQL is the maximum of the AOQs for all possible incoming qualities for a given acceptance sampling plan. AOQL values are given in table V-A for each of the single sampling plans for normal inspection and in table V-B for each of the single sampling plans for tightened inspection.

11.5 Average sample size curves

Average sample size curves for double and multiple sampling are in table IX. These show the average sample sizes which may be expected to occur under the various sampling plans for a given process quality. The curves assume no curtailment of inspection and are approximate to the extent that they are based upon the Poisson distribution, and that the sample sizes for double and multiple sampling are assumed to be 0,63 n and 0,25 n respectively, where n is the equivalent single sample size.

11.6 Limiting quality protection

The sampling plans and associated procedures given in this specification were designed for use where the units of product are produced in a continuing series of lots or batches over a period of time. However, if the lot or batch is of an isolated nature, it is desirable to limit the selection of sampling plans to those, associated with a designated AQL value, that provide not less than a specified limiting quality protection. Sampling plans for this purpose can be selected by choosing a limiting quality (LQ) and a consumer's risk to be associated with it. Tables VI and VII give values of LQ for the commonly used consumer's risks of 10% and 5% respectively. If a different value of consumer's risk is required, the O.C. curves and their tabulated values may be used.

The concept of LQ may also be useful in specifying the AQL and inspection levels for a series of lots or batches, thus fixing a minimum sample size where there is some reason for avoiding (with more than a given consumer's risk) more than a limiting proportion of defectives (or defects) in any single lot or batch.

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https://standards.iteh.ai/catalog/standards/sist/1a62f124-59ca-470c-a417-3f0f2049cb54/iso-2859-1974 $\mathsf{TABLE}\ \mathsf{I}-\mathsf{Sample}\ \mathsf{size}\ \mathsf{code}\ \mathsf{letters}\ (\mathsf{See}\ 9.2\ \mathsf{and}\ 9.3)$

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TABLE II-A – Single sampling plans for normal inspection (Master table) (See 9.4 and 9.5)

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Go up in this column till a block with acceptance-rejection numbers (Ac Re) is reached. Then use these numbers and the sample size on the same line to the left of this block.

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Rejection number. 11 Re

Ac

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NORMAL

TABLE II-B - Single sampling plans for tightened inspection (Master table) (See 9.4 and 9.5)



TABLE II-C -- Single sampling plans for reduced inspection (Master table) (See 9.4 and 9.5)

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Go down in this column till a block with acceptance-rejection numbers (Ac Re) is reached. Then use these numbers and the sample size on the same line to the left of this block. If the sample size equals or exceeds the lot or batch size, do 100 percent inspection. Go up in this column till a block with acceptance-rejection numbers (Ac Re) is reached. Then use these numbers and the sample size on the same line to the left of this block.

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Acceptance number. 11 Ac

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If the acceptance number has been exceeded, but the rejection number has not been reached, accept the lot, but reinstate normal inspection (see 10.1.4). II

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TABLE III-A - Double sampling plans for normal inspection (Master table) (See 9.4 and 9.5)

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DOUBLE

Acceptance number.

NORMAL 11